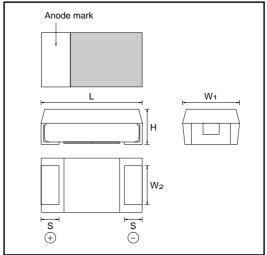
# Chip tantalum capacitors with open-function built-in

# **TCFG series P Case**

#### ●Features

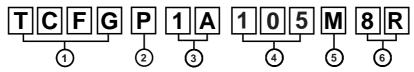
- 1) Safety design by open function built in.
- 2) Wide capacitance range
- 3) Screening by thermal shock.

#### ●External dimensions (Unit : mm)



Case code	L	W <sub>1</sub>	W <sub>2</sub>	Н	S
P (2012)	2.0±0.2	1.25±0.2	0.9±0.2	Max.1.20	0.45±0.3

#### Product designation



- 1 Series name
- 2 Case code
- 3 Rated Voltage

Rated voltage (V)		6.3				
CODE	0G	0J	1A	1C	1D	1E

(4) Capacitance

Nominal capacitance in pF in 3 digits: 2 significant figure representing the number of 0's.

(5) Capacitance tolerance

M: ±20% K: ±10%

- 6 Taping
  - 8 : Tape width (8mm)
  - R : Positive electrode on the side opposite to sprocket hole

#### ● Capacitance range

TCFG series P Case

		Rated voltage								
(μF)	4 0G	6.3 0J	10 1A	16 1C	20 1D	25 1E				
1.0 (105)			Р	Р	Р	Р				
1.5 (155)		Р	Р	Р						
2.2 (225)	Р	Р	Р	Р						
3.3 (335)	Р	Р	Р	Р						
4.7 (475)	Р	Р	Р							
6.8 (685)	Р	Р								
10 (106)	Р	Р								
15 (156)	Р	Р								
22 (226)	Р									
33 (336)										
47 (476)										
68 (686)										

Remark) Case size codes (P) in the above show each size products line-up.

#### Marking

The indications listed below should be given on the surface of a capacitor.

- ① Polarity : The polarity should be shown by  $\square$  bar. (on the anode side)
- ② Rated DC voltage: Due to the small size of P case, a voltage code is used as shown below.
- ③ Nominal capacitance

Voltage Code	Rated DC Voltage (V)
g	4
j	6.3
А	10
С	16
D	20
E	25

Capacitance Code	Nominal Capacitance (μF)
Α	1.0
E	1.5
J	2.2
N	3.3
S	4.7
W	6.8
а	10
е	15
j	22

Visual typical example (1) voltage code (2) capacitance code

[P Case] note 1) j J



note 2) voltage code and capacitance code are variable with parts number

#### ● Characteristics

Iten	1	Performance					form	ance	Test conditions (based on JIS C5101-1 and JIS C5101-3)		
Operating Tem	−55 °C to +125 °C							Voltage reduction when temperature exceeds +85°C			
Maximum operatir with no voltage de		+8	5 °C								
Rated Voltage	(V.DC)	4	6.3	10	16	3 20	25		at 85°C		
Category Volta	ge (V.DC)	2.5	4	6.3	10	13	16		at 125°C		
Surge Voltage		5.2	8	13	20	26	32		at 85°C		
DC leakage cu	rrent					CV wh		rer is greater	As per 4.9 JIS C 5101-1 As per 4.5.1 JIS C 5101-3 Voltage : Rated voltage for 1 min		
Capacitance to	lerance	1	all be			ed allo	wand	e range.	As per 4.7 JIS C 5101-1 As per 4.5.2 JIS C 5101-3 Measuring frequency : 120±12Hz Measuring voltage : 0.5Vrms, +1.5V.DC Measuring circuit : DC Equivalent series circu		
Tangent of loss angle (Df, $tan\delta$ ) Shall be satisfied the voltage on "Standard list"					As per 4.8 JIS C 5101-1 As per 4.5.3 JIS C 5101-3 Measuring frequency : 120±12Hz Measuring voltage : 0.5Vrms, +1.5V.DC Measuring circuit : DC Equivalent series circuit						
Impedance			Shall be satisfied the voltage on "Standard list"					ge on "Standard list"	As per 4.10 JIS C 5101-1 As per 4.5.4 JIS C 5101-3 Measuring frequency : 100±10kHz Measuring voltage : 0.5Vrms or less Measuring circuit : DC Equivalent series circuit		
Resistance to soldering heat	Appearance		There should be no significant abnormality. The indications should be clear.						As per 4.14 JIS C 5101-1 As per 4.6 JIS C 5101-3		
	L.C	Less than initial limit							Dip in the solder bath Solder temp : 260±5°C		
	ΔC / C	Within ±10% of initial value					valu	е	Duration : 5±0.5s		
	tanδ	Less than 150% of initial limit					tial li	nit	Repetition : 1		
Fail-Safe open	unit actuation	Within 320°C – 20s				- 20s			Dip in the solder bath Solder temp : 320±5°C		
Temperature cycle	Appearance	Th	ere s	houl	d b	e no s	ignific	ant abnormality.	As per 4.16 JIS C 5101-1 As per 4.10 JIS C 5101-3		
	L.C	Le	Less than initial limit						Repetition: 5 cycles (1 cycle: steps 1 to 4) without discontinuation.		
	ΔC / C	1						f initial value			
				•				of initial value	Step   Temp.   Time		
	tanδ	Le	ss th	an 1	50%	% of ini	tial lii	nit	2 Room temp. 3min. or less		
									3 125±2°C 30±3min		
									4 Room temp. 3min. or less		
Moisture resistance	Appearance					e no s		ant abnormality.	As per 4.22 JIS C 5101-1 As per 4.12 JIS C 5101-3		
i osistai 10 <del>0</del>	L.C	Le	ss th	an in	itia	l limit			After leaving the sample under such atmospher		
		Less than initial limit  Within ±20% of initial value					condition that the temperature and humidity are 60+2°C and 90 to 95%RH, respectively, for				
	ΔC / C	Wi	thin :	<u>-</u> 20%	6 o	f initia	valu	е	60±2°C and 90 to 95%RH, respectively, for		

Item		Performance	Test conditions (based on JIS C5101-1 and JIS C5101-3)			
Temperature	Temp.	−55°C	As per 4.29 JIS C 5101-1			
Stability	ΔC / C	Within 0/–15%of initial value	As per 4.13 JIS C 5101-3			
	tanδ	Shall be satisfied the voltage on "Standard list"				
	L.C	_				
	Temp.	+85°C				
	ΔC / C	Within +15/0%of initial value				
	tanδ	Shall be satisfied the voltage on "Standard list"				
	L.C	5μA or 0.1CV whichever is greater				
	Temp.	+125°C				
	ΔC / C	Within +20/0%of initial value				
	tanδ	Shall be satisfied the voltage on "Standard list"				
	L.C	6.3μA or 0.125CV whichever is greater				
Surge Voltage	Appearance	There should be no significant abnormality.	As per 4.26 JIS C 5101-1			
voltage	L.C	Shall be satisfied the voltage on "Standard list"	As per 4.14 JIS C 5101-3  Apply the specified surge voltage every 5±0.5mi for 30±5 s. each time in the atmospheric condition of 85±2°C.			
	ΔC / C	Within ±10%of initial value				
	tanδ	Less than 150% of initial limit	Repeat this procedure 1,000 times.			
Loading at	Appearance	There should be no significant abnormality.	As per 4.23 JIS C 5101-1			
High temperature	L.C	Less than initial limit	As per 4.15 JIS C 5101-3  After applying the rated voltage for 1000+36/0			
	ΔC / C	Within ±10%of initial value	without discontinuation via the serial resistance			
	tanδ	Less than 150% of initial limit	of $3\Omega$ or less at a temperature of $85\pm2^{\circ}$ C, lead the sample at room temperature/humidity for 1 to 2h and measure the value.			
Terminal	Capacitance	The measured value should be stable.	As per 4.35 JIS C 5101-1			
Strength	Appearance	There should be no significant abnormality.	As per 4.9 JIS C 5101-3 A force is applied to the terminal until it bends to 1mm and by a prescribed tool maintain the condition for 5s. (See the figure below.)  (Unit: mm) F (Apply force) R230 Thickness 1.6mm			
Adhesiveness		The terminal should not come off.	As per 4.34 JIS C 5101-1 As per 4.8 JIS C 5101-3 Apply force of 5N in the two directions shown in the figure below for 10±1s after mounting the terminal on a circuit board.  product  Apply force a circuit board			

# Tantalum capacitors

lt	tem	Performance	Test conditions (based on JIS C5101-1 and JIS C5101-3)
Dimensio	ns	Be based on "External dimensions"	Measure using a caliper of JIS B 7505 Class 2 or higher grade.
Resistance to solvents  Solderability		The indication should be clear.	As per 4.32 JIS C 5101-1 As per 4.18 JIS C 5101-3 Dip in the isopropyl alcohol for 30±5s, at room temperature.
		3/4 or more surface area of the solder coated terminal dipped in the soldering bath should be covered with the new solder.	As per 4.15.2 JIS C 5101-1 As per 4.7 JIS C 5101-3 Dip speed = 25±2.5mm/s Pre-treatment (accelerated aging): Leave the sample on the boiling distilled water for 1h. Solder temp.: 235±5°C Duration: 2±0.5s Solder: H63A Flux: Rosin 25%, IPA 75%
Vibration	Capacitance Appearance	Measure value should not fluctuate during the measurement.  There should be no significant abnormality.	As per 4.17 JIS C 5101-1 Frequency: 10 to 55 to 10Hz/min. Amplitude: 1.5mm Time: 2h each in X and Y directions Mounting: The terminal is soldered on a print circuit board.

# ●Table 1 standard list, TCFG series P Case

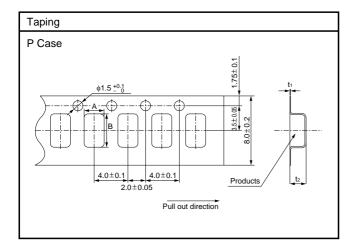
(P:2012)

										(P :	: 2012)
Part No.	Rated Voltage @85°C	Derated Voltage @125°C	Surge Voltage @85°C	Capacitance 120Hz (µF)	Tolerance (%)	Leakage current 25°C 1WV.60s	_55°C	F120H (%)	lz 125°C	Impedance 100kHz (Ω)	Case
-	(V)	(V)	(V)	(μ. )		(mA)	00 0	85°C		(22)	
TCFG P 0G 225□	4	2.5	5.2	2.2	±20,±10	0.5	15	10	15	4.0	Р
TCFG P 0G 335 □	4	2.5	5.2	3.3	±20,±10	0.5	30	20	30	17.5	Р
TCFG P 0G 475□	4	2.5	5.2	4.7	±20,±10	0.5	30	20	30	14.4	Р
TCFG P 0G 685 □	4	2.5	5.2	6.8	±20,±10	0.5	30	20	30	11.8	Р
TCFG P 0G 106□	4	2.5	5.2	10	±20,±10	0.5	30	20	30	9.3	Р
TCFG P 0G 156□	4	2.5	5.2	15	±20,±10	0.6	30	20	30	8.3	Р
TCFG P 0G 226 □	4	2.5	5.2	22	±20,±10	0.9	30	20	30	7.7	Р
TCFG P 0J 155 □	6.3	4	8	1.5	±20,±10	0.5	15	10	15	17.5	Р
TCFG P 0J 225□	6.3	4	8	2.2	±20,±10	0.5	30	20	30	4.0	Р
TCFG P 0J 335□	6.3	4	8	3.3	±20,±10	0.5	30	20	30	14.4	Р
TCFG P 0J 475□	6.3	4	8	4.7	±20,±10	0.5	30	20	30	11.8	Р
TCFG P 0J 685□	6.3	4	8	6.8	±20,±10	0.5	30	20	30	9.3	Р
TCFG P 0J 106□	6.3	4	8	10	±20,±10	0.6	30	20	30	8.3	Р
TCFG P 0J 156□	6.3	4	8	15	±20,±10	0.9	30	20	30	7.7	Р
TCFG P 1A 105□	10	6.3	13	1.0	±20,±10	0.5	15	10	15	17.5	Р
TCFG P 1A 155 □	10	6.3	13	1.5	±20,±10	0.5	30	20	30	16.1	Р
TCFG P 1A 225 □	10	6.3	13	2.2	±20,±10	0.5	30	20	30	4.0	Р
TCFG P 1A 335□	10	6.3	13	3.3	±20,±10	0.5	30	20	30	11.8	Р
TCFG P 1A 475□	10	6.3	13	4.7	±20,±10	0.5	30	20	30	6.0	Р
TCFG P 1C 105 □	16	10	20	1.0	±20,±10	0.5	15	10	15	16.5	Р
TCFG P 1D 105 □	20	13	26	1.0	±20,±10	0.5	15	10	15	16.1	Р
TCFG P 1E 105 □	25	16	33	1.0	±20,±10	0.5	15	10	15	16.1	Р

<sup>□=</sup>Tolerance (M: ±20%, K: ±10%)

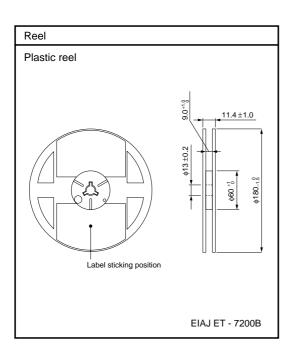
# Packaging specifications

Case code	A±0.1	B±0.1	t1±0.05	t2±0.1
P (2012)	1.55	2.3	0.25	1.5



# ●Packaging style

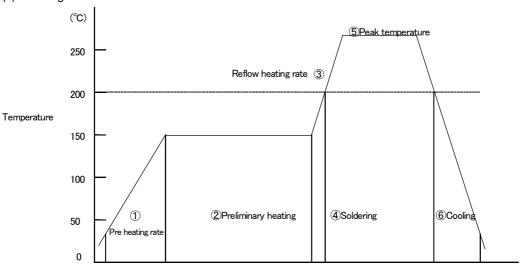
Case size	Packaging	ackaging Packaging s		Symbol	Basic ordering unit
P Case	Taping	Plastic taping	φ180mm reel	R	2,000



Rev.A

#### • Recommended condition of reflow soldering

(1) Soldering Conditions



# Recommended condition of reflow soldering

① Pre heating rate  $: 1 \text{ to } 5^{\circ}\text{C/ s}$ 

②Preliminary heating : 120 to 160°C, 50 to 120s

**4** Soldering : 200°C, 30 to 60s

⑤ Peak temperature : 230 to 260℃ 10s Max.

⑥ Cooling⑦ Time: 2times Max.

#### Recommended condition of hand soldering

①Temperature (30W Max.) : 300°C Max. ②Time : 5s Max.

#### Flow soldering (Dip • Wave soldering)

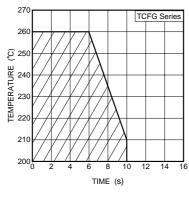


Fig.1

#### (2) Leakage current-to-voltage ratio

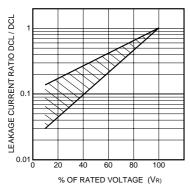
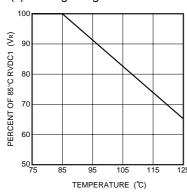


Fig.2

#### (3) Derating voltage as function of temperature



85	5°C	125°C			
Rated Voltage	Surge Voltage	Category Voltage	Surge Voltage		
(V.DC)	(V.DC)	(V.DC)	(V.DC)		
4	5.0	2.5	3.4		
6.3	8	4	5		
10	13	6.3	9		
16	16 20		12		
20	26	13	16		

Fig.3

### (4) Reliability

The malfunction rate of tantalum solid state electrolytic capacitors varies considerably depending on the conditions of usage (ambient temperature, applied voltage, circuit resistance).

#### Formula for calculating malfunction rate

 $\lambda p = \lambda b \times (\pi E \times \pi SR \times \pi Q \times \pi CV)$ 

 $\lambda p$  : Malfunction rate stemming from operation

 $\begin{array}{lll} \lambda b & : \mbox{Basic malfunction rate} \\ \pi E & : \mbox{Environmental factors} \\ \pi S R & : \mbox{Series resistance} \\ \pi Q & : \mbox{Level of malfunction rate} \end{array}$ 

 $\pi cv$ : Capacitance

For details on how to calculate the malfunction rate stemming from operation, see the tantalum solid state electrolytic capacitors column in MIL-HDBK-217.

# Malfunction rate as function of operating temperature and rated voltage

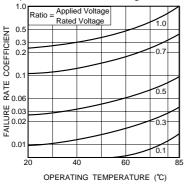
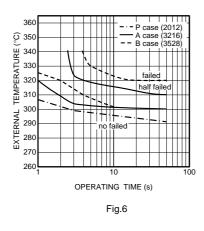


Fig.4

#### (5) External temperature vs. fuse blowout



Malfunction rate as function of circuit resistance ( $\Omega N$ )

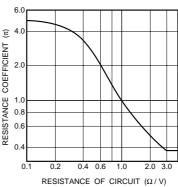


Fig.5

# (6) Power vs. fuse blowout characteristics / Product surface temperature

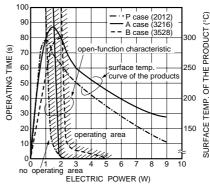


Fig.7

Note: Solder the chip at 300°C or less. If it is soldered using a temperature higher than 300°C, open function built-in may operate.

# (7) Maximum power dissipation

Warming of the capacitor due to ripple voltage balances with warming caused by Joule heating and by radiated heat. Maximum allowable warming of the capacitor is to 5°C above ambient temperature. When warming exceeds 5°C, it can damage the dielectric and cause a short circuit.

Power dissipation (P) =  $I^2 \cdot R$ 

Ripple current

P : As shown in table at right

R: Equivalent series resistance

# Notes:

- 1. Please be aware that when case size is changed, maximum allowable power dissipation is reduced.
- 2. Maximum power dissipation varies depending on the package. Be sure to use a case which will keep warming within the limits shown in the table below.

#### Allowable power dissipation (W) and maximum temperature rising

Case Ambient temp	+25°C	+55°C	+85°C	+125°C
P case (2012)	0.025	0.022	0.020	0.010
Max. Temp Rise (°C)	5	5	5	2

#### (8) Impedance frequency characteristics

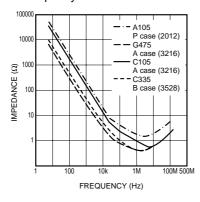


Fig.8

#### (9) ESR frequency characteristics

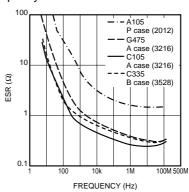


Fig.9

#### (10) Temperature characteristics

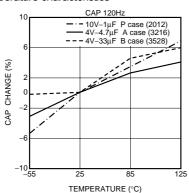
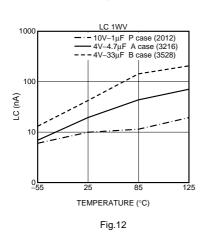


Fig.10



DF 120Hz

--10V-1μF P case (2012)
--4V-4.7μF A case (3216)
---4V-33μF B case (3528)

2

1

0–55

25

85

125

TEMPERATURE (°C)

Fig.11

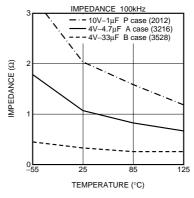


Fig.13

#### Inrush current

#### Beware of inrush current

Inrush currents are inversely proportional ESR. Large inrush currents can cause components failure.

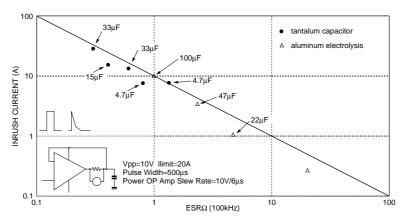


Fig. 14 Maximum inrush current and ESR

Inrush current can be limited by means of a protective resistor.

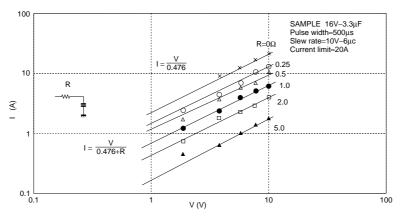


Fig. 15 Imax change due to protective resistor R

#### (11) Ultrasonic cleaning

Carry out cleaning under as mild conditions as possible. The internal element of a tantalum capacitor are larger than those of a transistor or diode, so it is not as resistant as ultrasonic waves.

Example: water

 $\begin{array}{ll} \mbox{Propagation speed} & \mbox{1500m/s} \\ \mbox{Solvent density} & \mbox{1g/cm}^{3} \end{array}$ 

Frequency and wavelength

Frequency	Wavelength	
20kHz	7.5cm	
28kHz	5.3cm	
50kHz	3.0cm	

# Tantalum capacitors

#### Precautions

- 1) Do not allow solvent to come to a boil (kinetic energy increases).
- . Ultrasonic output 0.5W / cm<sup>2</sup> or less
- . Use a solvent with a high boiling point.
- . Lower solvent temperature.
- 2) Ultrasonic cleaning frequency 28 kHz or less
- 3) Keep cleaning time as short as possible.
- 4) Move item being cleaned.
  Standing waves caused by the ultrasonic waves can cause stress to build up in part of the item being cleaned.

Reference

 $\label{eq:Kinetic energy} \text{Kin etic energy} = 2 \times \pi \times \text{frequency} \times \sqrt{\frac{2 \times \text{Ultrasonic output}}{\text{propagation} \times \text{speed} \times \text{solvent density}}}$ 

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